## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10511617	SCHULTZ, JUERGEN
Examiner	Art Unit
DEVONA E FAULK	2615

SEARCHED						
Class	Subclass	Date	Examiner			
381	86,91,92	2/3/06	DEF			
381	86,91,92	4/9/2008	DEF			
381	86 91 92 111 122	6/7 7/091	DEF			

SEARCH NOTES			
Search Notes	Date	Examiner	
Assignee/Inventor search	2/3/07	DEF	
Reviewed art submitted on IDS	2/3/07	DEF	
Additional search	10/18/07	DEF	
Reviewed applicant's arguments/maintained rejection	4/9/2008	DEF	
additional search	6/7,17/09	DEF	

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	

	/DEVONA E FAULK/ Primary Examiner.Art Unit 2614
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